



**International
Standard**

ISO 13695

**Optics and photonics — Lasers
and laser-related equipment —
Test methods for the spectral
characteristics of lasers**

**Second edition
2024-11**

*Optique et photonique — Lasers et équipement associé aux lasers
— Méthodes d'essai des caractéristiques spectrales des lasers*

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ISO copyright office
CP 401 • Ch. de Blandonnet 8
CH-1214 Vernier, Geneva
Phone: +41 22 749 01 11
Email: copyright@iso.org
Website: www.iso.org

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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular, the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

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This document was prepared by Technical Committee ISO/TC 172, *Optics and Photonics*, Subcommittee SC 9, *Laser and electro-optical systems*, in collaboration with the European Committee for Standardization (CEN) Technical Committee CEN/TC 123, *Lasers and photonics*, in accordance with the Agreement on technical cooperation between ISO and CEN (Vienna Agreement).

This second edition cancels and replaces the first edition (ISO 13595:2004) of which it constitutes a minor revision.

The main changes are as follows:

- editorial changes related to the new format;
- the symbol for side-mode suppression ratio was adapted from *SMS* to R_{SMS} ;
- *lg* was changed to \log_{10} in [3.15](#);
- the title of the SC 9 was updated;
- intensity was adapted to irradiance;
- in the Bibliography Reference 2 was updated and replaced by References 2 and 3.

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at www.iso.org/members.html.

Introduction

The spectral characteristics of a laser, such as its peak wavelength or spectral linewidth, are important for potential applications. Examples are the specific application requirements of interferometry and lithography. This document gives definitions of key parameters describing the spectral characteristics of a laser, and provides guidance on performing measurements to determine these parameters for common laser types.

The acceptable level of uncertainty in the measurement of wavelength will vary according to the intended application. Therefore, equipment selection and measurement and evaluation procedures are outlined for three accuracy classes. To standardize reporting of spectral characteristics measurement results, a report example is also included.

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Optics and photonics — Lasers and laser-related equipment — Test methods for the spectral characteristics of lasers

1 Scope

This document specifies methods by which the spectral characteristics such as wavelength, bandwidth, spectral distribution and wavelength stability of a laser beam can be measured. This document is applicable to both continuous wave (cw) and pulsed laser beams. The dependence of the spectral characteristics of a laser on its operating conditions may also be important.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 11145, *Optics and photonics — Lasers and laser-related equipment — Vocabulary and symbols*

ISO/IEC Guide 99, *International vocabulary of metrology — Basic and general concepts and associated terms (VIM)*

IEC 60747-5-1, *Discrete semiconductor devices and integrated circuits — Part 5-1: Optoelectronic devices — General*

3 Terms and definitions

For the purposes of this document, the terms and definitions given in ISO 11145, ISO/IEC Guide 99 and IEC 60747-5-1, and the following apply.

ISO and IEC maintain terminology databases for use in standardization at the following addresses:

— ISO Online browsing platform: available at <https://www.iso.org/obp>

— IEC Electropedia: available at <https://www.electropedia.org/>

3.1

wavelength in vacuum

λ_0

wavelength of an infinite, plane electromagnetic wave propagating in vacuum

Note 1 to entry: For a wave of frequency f , the wavelength in vacuum is then given by $\lambda_0 = c/f$, where $c = 299\,792\,458$ m/s.

3.2

wavelength in air

λ_{air}

wavelength of radiation propagating in the air and related to the wavelength in vacuum by the relationship:

$$\lambda_{\text{air}} = \lambda_0 / n_{\text{air}}$$

where n_{air} denotes the refractive index of ambient air (see 6.4)

Note 1 to entry: The specific properties of the ambient atmosphere, such as humidity, pressure, temperature and composition all influence n_{air} . Therefore it is better to report the wavelength in vacuum, or the wavelength in standard air. These can be calculated from λ_{air} and n_{air} using the equation given in 6.4.

3.3 wavelength in dry air under standard conditions

λ_{std}
wavelength of radiation propagating in dry air (0 % humidity) under standard conditions and related to the wavelength in vacuum λ_0 by the relationship:

$$\lambda_{std} = \lambda_0 / n_{std}$$

where n_{std} denotes the refractive index of air under standard conditions (see 6.4).

Note 1 to entry: For the purpose of this document, air under standard conditions is as defined in 6.4. Note that various other “standard conditions” have been reported in the literature. It is therefore necessary to quote the conditions in the test report.

3.4 spectral radiant power [energy] distribution

$P_\lambda(\lambda)$, [$Q_\lambda(\lambda)$]
ratio of the radiant power $dP(\lambda)$ [or energy $dQ(\lambda)$ in the case of a pulsed laser] transferred by laser beam in the range of wavelength $d\lambda$ to that range

$$P_\lambda(\lambda) = \frac{dP(\lambda)}{d\lambda} \quad \left[Q_\lambda(\lambda) = \frac{dQ(\lambda)}{d\lambda} \right]$$

Note 1 to entry: The radiant power (energy) delivered by the laser beam in any bandwidth λ_{low} to λ_{high} is then given by the integral:

$$P = \int_{\lambda_{low}}^{\lambda_{high}} P_\lambda(\lambda) d\lambda \quad \left[Q = \int_{\lambda_{low}}^{\lambda_{high}} Q_\lambda(\lambda) d\lambda \right]$$

3.5 peak-emission wavelength

λ_p
wavelength at which the spectral radiant power (energy) distribution has its maximum value

Note 1 to entry: See Figure 1.

3.6 weighted average wavelength (first moment)

λ_g
wavelength representing the centre of gravity of the spectral radiant power (energy) distribution, as defined by:

$$\lambda_g = \frac{\int_{\lambda_{min}}^{\lambda_{max}} \lambda S(\lambda) d\lambda}{\int_{\lambda_{min}}^{\lambda_{max}} S(\lambda) d\lambda}$$

where $S(\lambda)$ is the spectral radiant power $P_\lambda(\lambda)$ in the case of a cw laser, or the spectral radiant energy distribution $Q_\lambda(\lambda)$ in the case of a pulsed laser

Note 1 to entry: See Figure 1.

Note 2 to entry: For choosing of the integration limits λ_{min} and λ_{max} , see 6.2.2.

3.7 central wavelength

$\bar{\lambda}$

weighted average of the wavelengths of spectral lines or modes:

$$\bar{\lambda} = \frac{\sum_{i=i_{\min}}^{i=i_{\max}} I_i \lambda_i}{\sum_{i=i_{\min}}^{i=i_{\max}} I_i}$$

where

λ_i is the wavelength of the i th spectral line or the i th mode;

I_i is the relative radiant power of the i th spectral line or the i th mode;

i_{\min}, i_{\max} denote extreme spectral lines or modes below and above λ_p .

Note 1 to entry: Usually, the summation limits are chosen such that the relative radiant power of spectral lines or modes outside the limits remains less than 1 % of the relative radiant power of the strongest line or mode, located at λ_p .

Note 2 to entry: This definition is particularly useful in the case of a multi-mode laser.

3.8 average wavelength

λ_{av}
ratio of the light velocity c to the average optical emission frequency f_{av}

$$\lambda_{\text{av}} = c/f_{\text{av}}$$

Note 1 to entry: The average optical emission frequency f_{av} can be measured directly, e.g. by the heterodyne measurement method (see 6.6.5).

3.9 RMS spectral radiation bandwidth (second moment)

$\Delta\lambda$
second moment of the spectral radiant power (energy) distribution, as defined by:

$$\Delta\lambda = \sqrt{\frac{\int_{\lambda_{\min}}^{\lambda_{\max}} (\lambda - \lambda_g)^2 S(\lambda) d\lambda}{\int_{\lambda_{\min}}^{\lambda_{\max}} S(\lambda) d\lambda}}$$

where $S(\lambda)$ is the spectral radiant power $P_\lambda(\lambda)$ in the case of a cw laser, or the spectral radiant energy distribution $Q_\lambda(\lambda)$ in the case of a pulsed laser.

Note 1 to entry: See [Figure 1](#).

Note 2 to entry: For choosing of the integration limits λ_{\min} and λ_{\max} see [6.2.2](#).

3.10 RMS spectral bandwidth

$\Delta\lambda_{\text{rms}}$
rms bandwidth is defined by:

$$\Delta\lambda_{\text{rms}} = \sqrt{\frac{\sum_{i=i_{\min}}^{i=i_{\max}} I_i (\lambda_i - \bar{\lambda})^2}{\sum_{i=i_{\min}}^{i=i_{\max}} I_i}}$$

where

- λ_i is the wavelength of the i th spectral line or the i th mode;
- I_i is the relative radiant power of the i th spectral line or the i th mode;
- $\bar{\lambda}$ is the central wavelength;
- i_{\min}, i_{\max} denote extreme spectral lines or modes below and above λ_p

Note 1 to entry: See [Figure 1](#).

Note 2 to entry: Usually, the summation limits are chosen such that the relative radiant power of spectral lines outside the limits remains less than 1 % of the relative radiant power of the strongest line, located at λ_p .

Note 3 to entry: This definition is particularly useful in the case of a multi-mode laser.

3.11 spectral bandwidth FWHM

$\Delta\lambda_H$
maximum difference between the wavelengths for which the spectral radiant power (energy) distribution is half of its peak value

Note 1 to entry: See [Figure 1](#).

[SOURCE: ISO 11145:2018, 3.17, modified — The abbreviation “FWHM” has been added, “ $\Delta\lambda$, $\Delta\nu$ ” has been replaced by “ $\Delta\lambda_H$ ” and Note 1 to entry has been added.]

3.12 spectral linewidth FWHM

$\Delta\lambda_L$
maximum difference between those wavelengths within $\delta\lambda$ for which the spectral radiant power (energy) distribution is half of its peak value found within $\delta\lambda$

Note 1 to entry: See [Figure 1](#).

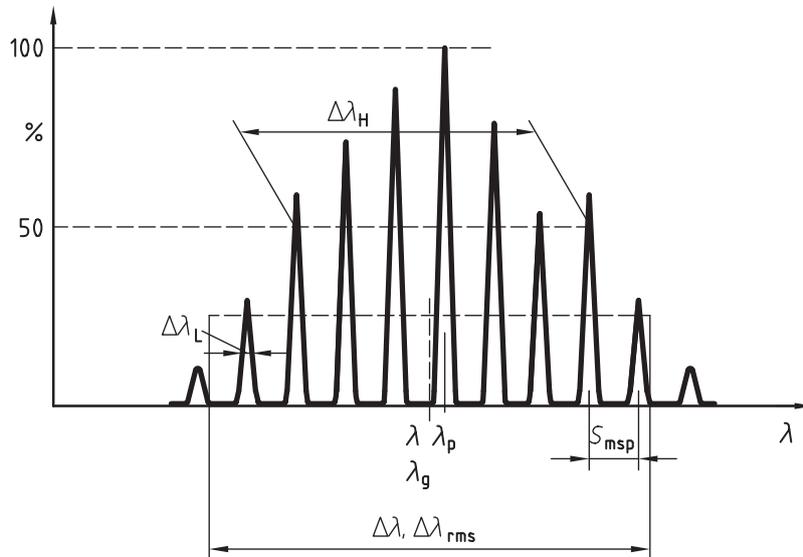
Note 2 to entry: cf. *spectral bandwidth* ([3.11](#)), $\Delta\lambda_H$ [ISO 13695:2024](https://standards.iteh.ai/catalog/standards/iso/bd39c1b0-0234-4bbb-9cdb-497ea3bde688/iso-13695-2024)

Note 3 to entry: A spectral linewidth is analogous to a *spectral bandwidth* ([3.11](#)), but is defined for a single (longitudinal) mode or otherwise clearly distinguishable and labelled spectral feature contained within an interval $\delta\lambda$.

3.13 mode spacing

$F_{\text{msp}} (S_{\text{msp}})$
separation of two neighbouring longitudinal modes expressed in frequency (F_{msp}) (wavelength (S_{msp}))

Note 1 to entry: See [Figure 1](#).



Key

λ wavelength

Figure 1 — Spectral characteristics of lasers — Illustration of defined parameters

3.14

number of longitudinal modes

N_m
number of longitudinal modes within a specified bandwidth, usually the rms spectral bandwidth $\Delta\lambda_{rms}$

3.15

side-mode suppression ratio

R_{SMS}
ratio of the relative radiant power of the most intense mode, I_p , located at λ_p , to the relative radiant power of the second most intense mode, I_s , located at λ_s :

$$R_{SMS} = 10 \log_{10} \left(\frac{I_p}{I_s} \right)$$

Note 1 to entry: See [Figure 2](#).

Note 2 to entry: In practice the R_{SMS} can be assumed to be equal to the ratio of the peak values of the spectral distribution for the most intense and second most intense modes:

$$R_{SMS} = 10 \log_{10} \left[\frac{S(\lambda_p)}{S(\lambda_s)} \right]$$